Attorney's Docket No.: 12732-189001 / US6847

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Hideaki Kuwabara et al. Art Unit: 2822

Serial No.: 10/735,767 Examiner: Kevin Picardat

Filed: December 16, 2003 Conf. No.: 4086

Title : SEMICONDUCTOR DEVICE AND METHOD FOR MANUFACTURING THE

SAME

MAIL STOP AF

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This information disclosure statement is being filed concurrently with a Request for Continued Examination. The fee in the amount of \$790.00 in payment of the Request for Continued Examination fee is being paid concurrently herewith on the Electronic Filing System (EFS) by way of Deposit Account authorization. Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: Janaury 4, 2007

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-189001	Application No. 10/735,767	
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Hideaki Kuwabara et al.		
		Filing Date December 16, 2003	Group Art Unit 2822	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2002/0055237	05/09/2002	Sayyah			09/12/2001
-	AB	6,027,958	02/22/2000	Vu et al.			07/11/1996
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	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL					_		
	AM							<u>. </u>
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner Initial	Desig. ID	Document		
	AQ			
	AR			
	AS			
	AT			

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if n	ot in conformance and not considered. Include copy of this form with
next communication to applicant.	Substitute Disclosure Form (PTO-1449)